



FCC REPORT

For LTE

Report No.:: CHTEW22120052 Report Verification:

Project No.....: SHT2208214102EW

FCC ID.....:: SS4SF650

Applicant: **BLUEBIRD INC.**

Address....: 3F, 115, Irwon-ro, Gangnam-gu, Seoul, Republic of Korea

Product Name:: **Smart Full Touch Handheld Computer**

Trade Mark: **BLUEBIRD**

Model No. SF650

Listed Model(s):

FCC CFR Title 47 Part 2 Standard::

> FCC CFR Title 47 Part 22 FCC CFR Title 47 Part 24

FCC CFR Title 47 Part 27

Date of receipt of test sample.....: Nov.15, 2022

Date of testing.....: Nov.16, 2022-Dec.07, 2022

Date of issue..... Dec.08, 2022

Result....: Pass

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The test report merely correspond to the test sample.

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1. TEST STANDARDS AND REPORT VERSION

1.1. Applicable Standards

The tests were performed according to following standards:

FCC Rules Part 2: FREQUENCY ALLOCATIONS AND RADIO TREATY MATTERS; GENERAL RULES AND REGULATIONS

FCC Rules Part 22: PUBLIC MOBILE SERVICES

FCC Rules Part 24: PERSONAL COMMUNICATIONS SERVICES

FCC Rules Part 27: MISCELLANEOUS WIRELESS COMMUNICATIONS SERVICES

ANSI C63.26: 2015: American National Standard for Compliance Testing of Transmitters Used in Licensed Radio Services

KDB 971168 D01 Power Meas License Digital Systems v03: MEASUREMENT GUIDANCE FOR CERTIFICATION OF LICENSED DIGITAL TRANSMITTERS

1.2. Report version information

Revision No.	Date of issue	Description
N/A	2022-12-08	Original

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2. TEST DESCRIPTION

Section	Test Item	Section in CFR 47	Result #1	Test Engineer
5.1	Conducted Output Power	Part 2.1046 Part 22.913(a) Part 24.232(c) Part 27.50	Pass	Xiaodong Zhao
5.2	Peak-to-Average Ratio	Part 24.232 Part 27.50	Pass	Xiaodong Zhao
5.3	99% Occupied Bandwidth & 26 dB Bandwidth	Part 2.1049 Part 22.917(b) Part 24.238(b) Part 27.53	Pass	Xiaodong Zhao
5.4	Band Edge	Part 2.1051 Part 22.917 Part 24.238 Part 27.53	Pass	Xiaodong Zhao
5.5	Conducted Spurious Emissions	Part 2.1051 Part 22.917 Part 24.238 Part 27.53	Pass	Xiaodong Zhao
5.6	Frequency stability vs temperature	Part 2.1055(a)(1)(b) Part 22.355 Part 24.235 Part 27.54	Pass	Xiaodong Zhao
5.7	Frequency stability vs voltage	Part 2.1055(d)(1)(2) Part 22.355 Part 24.235 Part 27.54	Pass	Xiaodong Zhao
5.8	ERP and EIRP	Part 22.913(a) Part 24.232(b) Part 27.50	Pass	Xiaodong Zhao
5.9	Radiated Spurious Emissions	Part 2.1053 Part 22.917 Part 24.238 Part 27.53	Pass	Yifan Wang

Report Template Version: V04 (2022-01)

Note:

#1: The test result does not include measurement uncertainty value

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3. **SUMMARY**

3.1. Client Information

Applicant:	BLUEBIRD INC.
Address:	3F, 115, Irwon-ro, Gangnam-gu, Seoul, Republic of Korea
Manufacturer:	BLUEBIRD INC.
Address:	3F, 115, Irwon-ro, Gangnam-gu, Seoul, Republic of Korea
Factory1:	Bluebird Inc.
Address:	SSang-young IT Twin tower-B 7~8F), 531, Dunchon-daero, Jungwongu, Seongnam-si, Gyeonggi-do, Korea
Factory2:	TOP INTERCUBE ELECTRONICS VINA CO., LTD
Address:	Lo C1,Ba thien II Industrial park, Thien Ke Ward, Binh Xuyen District,Vinh Phuc Province, Vietnam

3.2. Product Description

Main unit information:						
Product Name:	Smart Full Touch Handheld Computer					
Trade Mark:	BLUEBIRD					
Model No.:	SF650					
Listed Model(s):	-					
Power supply:	DC 3.85V from Battery					
Hardware version:	V01					
Software version:	SF650-AND12-EN-20221119_R1.00-user					
Accessory unit information:						
	Model: BAT-500001					
	Type: LI-ION POLYMER BATTERY					
Bottom, information,	Rated/Min: 4850mAh, 18.67Wh					
Battery information:	Typical Capacity: 5000mAh, 19.25Wh					
	Limited Charge Voltage: 4.4V					
	Nominal Voltage: 3.85V					
	Model: KSA29B0500200D5					
Adapter information:	Input: 100-240Va.c., 50/60Hz 0.5A					
	Output: 5.0Vd.c., 2.0A 10.0W					

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3.3. Radio Specification Description

	⊠ FDD Band 2	⊠ FDD	Band 4	☑ FDD Band 5		
Support Operating Band:	⊠ FDD Band 7	⊠ FDD	Band 12	⊠ FDD Band 13		
	⊠ FDD Band 66					
Operating Frequency Range:	Please refer to r	note #2				
Channel bandwidth:	Please refer to r	note #3				
Uplink Modulation type:	⊠ QPSK	⊠ 16QAM	⊠ 64QAM	☐ 256QAM		
Downlink Modulation type:	⊠ QPSK	⊠ 16QAM	⊠ 64QAM	☐ 256QAM		
Antenna type:	LOOP					
Antenna gain #4:	LTEB2:-1.5dBi LTEB12:-4dBi	LTEB4:-1dBi LTEB13:-3dBi	LTEB5:-2dBi LTEB66:-1dBi	LTEB7:-2dBi		

Note:

- O 🔯: means that this feature is supported; 🗀: means that this feature is not supported
- O #2: Operating frequency range is as follow:

LTE Band	Uplink frequency	Downlink frequency
FDD Band 2	1850.7 – 1909.3 MHz	1930.7 – 1989.3 MHz
FDD Band 4	1710.7 – 1754.3 MHz	2110.7 – 2154.3 MHz
FDD Band 5	824.7 - 848.3 MHz	869.7 – 893.3 MHz
FDD Band 7	2502.5 – 2567.5 MHz	2622.5 – 2687.5 MHz
FDD Band 12	699.7 – 715.3 MHz	729.7 – 745.3 MHz
FDD Band 13	779.5 – 784.5 MHz	748.5 – 753.5 MHz
FDD Band 66	1710.7 – 1779.3 MHz	2110.7 – 2179.3 MHz

O Supported channel bandwidth is as follow:

LTE Band	1.4MHz	3MHz	5MHz	10MHz	15MHz	20MHz
FDD Band 2	√	\checkmark	\checkmark	\checkmark	\checkmark	√
FDD Band 4	√	√	√	√	√	√
FDD Band 5	√	√	√	√	-	-
FDD Band 7	-	-	√	√	√	√
FDD Band 12	√	√	√	√	-	-
FDD Band 13	-	-	√	√	-	-
FDD Band 66	√	√	√	√	√	√

^{√:} means that this feature is supported; -: means that this feature is not supported

 ^{#4:} The antenna gain is provided by the applicant, and the applicant should be responsible for its authenticity, HTW lab has not verified the authenticity of its information

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3.4. Testing Laboratory Information

Laboratory Name	Shenzhen Huatongwei International Inspection Co., Ltd.				
Laboratory Location	1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao, Gongming, Shenzhen, China				
Connect information:	Tel: 86-755-26715499 E-mail: cs@szhtw.com.cn http://www.szhtw.com.cn				
Qualifications	Туре	Accreditation Number			
Qualifications	FCC	762235			

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4. TEST CONFIGURATION

4.1. Test frequency list

Test Frequency	Bandwidth	NuL	Frequency of	N _{DL}	Frequency of
ID	[MHz]		Uplink [MHz]		Downlink [MHz]
					1930.7 1931.5
Low Papas	5	18625	1852.5	625	1932.5
Low Range	10	18650	1855	650	1935
					1937.5 1940
Mid Range					
					1960
					1989.3 1988.5
	5	19175	1907.5	1175	1987.5
High Range	10	19150	1905	1150	1985
	15 [1]				1982.5
NOTE 1: Bandwidth					1980 nuirement (TS
36.101 [2]	7] Clause 7.3) is al	lowed.		Joniola Nity To	quii oiii (10
Test Frequency ID	Bandwidth [MHz]	NuL	Frequency of Uplink (MHz)	N _{DL}	Frequency of Downlink
			' ' '		[MHz]
					2110.7 2111.5
					2111.5
Low Range	10	20000	1715	2000	2115
] [15	20025	1717.5	2025	2117.5
Mid Danne					2120 2132.5
wiid Range					2132.5
1	3	20385	1753.5	2385	2153.5
High Range	5	20375	1752.5	2375	2152.5
. ngn r sange					2150
]		20325		2325	2147.5 2145
'			1		
Test Frequency ID	Bandwidth [MHz]	N _{UL}	Frequency of Uplink [MHz]	N _{DL}	Frequency of Downlink [MHz]
	1.4	20407	824.7	2407	869.7
Low Range	3	20415	825.5	2415	870.5
20w Marige	5	20425	826.5	2425	871.5
					874
Mid Range	10 [1]	20525	836.5	2525	881.5
	1.4	20643	848.3	2643	893.3
High Range	3	20635	847.5	2635	892.5
	5 10 [1]				891.5 889
	or which a relaxation	on of the spec			
Test Frequency ID	Bandwidth [MHz]	N _{UL}	Frequency of Uplink [MHz]	N _{DL}	Frequency of Downlink [MHz]
					2622.5 2625
Low Range					2627.5
	20 [1]	20850	2510	2850	2630
Mid Range	5/10/15	21100	2535	3100	2655
					2687.5
High Dangs	10	21400	2565	3400	2685
riign Kange	15	21375	2562.5	3375	2682.5
NOTE 1: Bandwidth 6		21350	2560		2680
			aned OE receiver ser	isiuvity requi	rement (13
Table 4.3.1.1.12-1:	Test frequencie	s for E-UTF	RA channel band	width for o	perating band 12
					<u> </u>
Test Frequency ID	Bandwidth [MHz]	NuL	Frequency of Uplink [MHz]	N _{DL}	Frequency of Downlink [MHz]
			-pav partiej	5017	729.7
	1.4	23017	699.7		730.5
Low Range	1.4 3	23025	700.5	5025	
Low Range	1.4 3 5 ^[1]	23025 23035	700.5 701.5	5035	731.5
	1.4 3 5 [1] 10 [1] 1.4/3	23025 23035 23060	700.5 701.5 704	5035 5060	731.5 734
Low Range	1.4 3 5 [1] 10 [1] 1.4/3 5 [1]/10 [1]	23025 23035 23060 23095	700.5 701.5 704 707.5	5035 5060 5095	731.5 734 737.5
	1.4 3 5 [1] 10 [1] 1.4/3 5 [1]/10 [1] 1.4	23025 23035 23060 23095	700.5 701.5 704 707.5 715.3	5035 5060 5095 5173	731.5 734 737.5 745.3
	1.4 3 5 (1) 10 (1) 1.4/3 5 (1)/10 (1) 1.4 3	23025 23035 23060 23095 23173 23165	700.5 701.5 704 707.5 715.3 714.5	5035 5060 5095 5173 5165	731.5 734 737.5 745.3 744.5
Mid Range	1.4 3 5 [1] 10 [1] 1.4/3 5 [1]/10 [1] 1.4	23025 23035 23060 23095	700.5 701.5 704 707.5 715.3	5035 5060 5095 5173	731.5 734 737.5 745.3
Mid Range High Range NOTE 1: Bandwidth	1.4 3 5 (1) 10 (1) 1.4/3 5 (1)/10 (1) 1.4 3 5 (1)	23025 23035 23060 23095 23173 23165 23155 23130 ion of the spe	700.5 701.5 704 707.5 715.3 714.5 713.5 711	5035 5060 5095 5173 5165 5155 5130	731.5 734 737.5 745.3 744.5 743.5 741
Mid Range High Range NOTE 1: Bandwidth (TS 36.101	1.4 3 5 [1] 10 [1] 1.4/3 5 [1]/10 [1] 1.4 3 5 [1] 10 [1] for which a relaxat [27] Clause 7.3) is	23025 23035 23060 23095 23173 23165 23155 23130 ion of the spe	700.5 701.5 704 707.5 715.3 714.5 713.5 711 coffied UE receiver s	5035 5060 5095 5173 5165 5155 5130 ensitivity requ	731.5 734 737.5 745.3 744.5 743.5 741 Jirement
Mid Range High Range NOTE 1: Bandwidth (TS 36.101) Test Frequency ID	1.4 3 5 [1] 10 [1] 1.4/3 5 [1]/10 [1] 1.4/3 5 [1]/10 [1] 1.4 3 5 [1] 10 [1] for which a relaxat [27] Clause 7.3) is	23025 23035 23060 23095 23173 23165 23155 23155 23130 ion of the spe	700.5 701.5 701.5 704 707.5 715.3 714.5 713.5 711 ccified UE receiver s	5035 5060 5095 5173 5165 5155 5130 ensitivity requ	731.5 734 737.5 745.3 744.5 743.5 741 Jirement Frequency of Downlink [MHz]
Mid Range High Range NOTE 1: Bandwidth (TS 36.101) Test Frequency ID Low Range	1.4 3 5 [1] 10 [1] 1.4/3 5 [1]/10 [1] 1.4 3 5 [1]/10 [1] 1.4 3 5 [1] 10 [1] for which a relaxat [27] Clause 7.3) is Bandwidth [MHz] 5 [1] 10 [1]	23025 23035 23060 23095 23173 23165 23155 23130 ion of the spe 3 allowed.	700.5 701.5 701.5 704 707.5 715.3 714.5 711.5 711 bedified UE receiver s Frequency of Uplink [MHz] 779.5 782	5035 5060 5095 5173 5165 5155 5130 ensitivity requ	731.5 734 737.5 745.3 744.5 743.5 741 irrement Frequency of Downlink [MHz] 748.5 751
Mid Range High Range NOTE 1: Bandwidth (TS 36.101) Test Frequency ID	1.4 3 5 [1] 10 [1] 1.4/3 5 [1]/10 [1] 1.4/3 5 [1]/10 [1] 1.4 3 5 [1] 10 [1] for which a relaxat [27] Clause 7.3) is Bandwidth [MHz] 5 [1] 10 [1] 5 [1]/10 [1]	23025 23035 23036 23095 23173 23165 23155 23130 ion of the spe 3 allowed.	700.5 701.5 701.5 704 707.5 715.3 714.5 713.5 711.5 crified UE receiver s Frequency of Uplink [MHz] 779.5 782 782	5035 5060 5095 5173 5165 5155 5130 ensitivity required.	731.5 734 737.5 745.3 744.5 743.5 741 sirement Frequency of Downlink [MHz] 748.5 751 751
Mid Range High Range NOTE 1: Bandwidth (TS 36.101) Test Frequency ID Low Range	1.4 3 5 [1] 10 [1] 1.4/3 5 [1]/10 [1] 1.4 3 5 [1]/10 [1] 1.7 [1.4]	23025 23035 23060 23095 23173 23165 23155 23130 ion of the spe allowed. Nu. 23205 23230 23230 23250	700.5 701.5 701.5 704 707.5 715.3 714.5 713.5 711 cified UE receiver s Frequency of Uplink [MHz] 779.5 782 782 784.5	5035 5060 5095 5173 5165 5155 5130 ensitivity requ No. 5205 5230 5230 5255	731.5 734 737.5 745.3 744.5 743.5 741 Jirement Frequency of Downlink [MHz] 748.5 751 751 753.5
Mid Range High Range NOTE 1: Bandwidth (TS 36.101 Test Frequency ID Low Range Mid Range High Range NOTE 1: Bandwidth	1.4 3 5 [1] 10 [1] 1.4/3 5 [1]/10 [1] 1.4 3 5 [1] 10 [1] 10 [1] 10 [1] for which a relaxat [27] Clause 7.3) is Bandwidth [MHz] 5 [1] 10 [1] 5 [1]/10 [1] 5 [1]/10 [1]	23025 23035 23060 23096 23173 23165 23135 23130 ion of the spe allowed. Nu. 23205 23230 23230 23230 23255 23230 23255 23230 23255 23230 23255	700.5 701.5 701.5 704 707.5 715.3 714.5 713.5 711 ecified UE receiver s Frequency of Uplink [MHz] 779.5 782 782 784.5 782	5035 5060 5095 5173 5165 5155 5155 5130 Ensitivity required.	731.5 734 737.5 745.3 744.5 743.5 741 irrement Frequency of Downlink [MHz] 748.5 751 751 753.5 751
	High Range NOTE 1: Bandwidth 36.101 [2] Test Frequency ID Low Range High Range High Range Mid Range NOTE 1: Bandwidth f 36.101 [27] Test Frequency ID Low Range NOTE 1: Bandwidth f 36.101 [27]	Low Range	Low Range	Low Range	Low Range

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	Test Frequency ID	Bandwidth [MHz]	NuL	Frequency of Uplink [MHz]	N _{DL}	Frequency of Downlink [MHz]
		1.4	131979	1710.7	66443	2110.7
		3	131987	1711.5	66451	2111.5
	Low Range	5	131997	1712.5	66461	2112.5
	Low Range	10	132022	1715	66486	2115
		15	132047	1717.5	66511	
		20	132072	1720	66536	2120
	Mid Range Tx1	1.4/3/5/10/15/20	132322	1745	66786	2145
	Mid Range	1.4/3/5/10/15/20	132422	1755	66886	2155
		1.4	132665	1779.3	67129	2179.3
		3	132657	1778.5	67121	2178.5
	Paired High	5	132647	1777.5	67111	2177.5
	Range ²	10	132622	1775	67086	2175
		15	132597	1772.5	67061	2172.5
		20	132572	1770	67036	2170
		1.4	NA	NA	67329	2199.3
		3	NA	NA	67321	2198.5
	High Range ³	5	NA	NA	67311	2197.5
	nigh Range	10	NA	NA	67286	2195
		15	NA	NA	67261	2192.5
	1 1	20	NA	NA	67236	2190

4.2. Descriptions of Test mode

Antenna port conducted and radiated test items were performed according to KDB 971168 D01 Power Meas. License Digital Systems and ANSI C63.26 with maximum output power.

Radiated measurements were performed with rotating EUT in different three orthogonal test planes to find the maximum emission.

Test configuration is as follow:

Test Items	Bandwidth	Modulation		RB#		
rest items	Danuwiutii	Modulation	1	Full		
Conducted Output Power	#5	#6	0	0	0	
Peak-to-Average Ratio	#5	#6	0	-	0	
99% Occupied Bandwidth & 26 dB Bandwidth	#5	#6	-	-	0	
Band Edge	#5	#6	0	-	0	
Conducted Spurious Emission	#5	#6	0	-	-	
Frequency Stability	#5	#6	-	-	0	
ERP and EIRP	#5	#6	0	0	0	
Radiated Spurious Emission	#5	#6	0	-	-	

Note:

- O #5: Test all kind of bandwith in section 3.3
- O #6: Test all kind of uplink modulation in section 3.3
- O o: means that this configuration is chosen for testing
- O -: means that this configuration is not test.
- O The device is investigatedfrom 30MHz to10 times offundamental signal for radiated spurious emission test under different bandwidth,modulations and RB size/offset in exploratory test. Subsequently, only the worst case emissions(highest bandwidth,QPSK,and 1RB0) are reported.

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4.3. Test sample information

Test item	HTW sample no.		
Conducted test items	Please refer to the description in the appendix report		
Radiated test items	YPHT22082141010		

Note:

Conducted test items: Conducted Output Power, Peak-Average Ratio, 99% Occupied Bandwidth & 26 dB

Bandwidth, Band Edge, Conducted Spurious Emissions, Frequency stability, ERP and

EIRP

Radiated test items: Radiated Spurious Emission

4.4. Support unit used in test configuration and system

The EUT has been associated with peripherals and configuration operated in a manner tended to maximize its emission characteristics in a typical application.

The following peripheral devices and interface cables were connected during the measurement:

Whether support unit is used?						
✓	No					
Item	Equipment	Trade Name	Model No.	Other		
1						
2						

4.5. Testing environmental condition

	VN=Nominal Voltage	DC 3.85V	
Voltage	VL=Lower Voltage	DC 3.6V	
	VH=Higher Voltage	DC 4.4V	
Tomporatura	TN=Normal Temperature	25 °C	
Temperature	Extreme Temperature	From -30°C to + 50°C	
Humidity	30~60 %		
Air Pressure	950-1050 hPa		

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4.6. Statement of the measurement uncertainty

No.	Test Items	Measurement Uncertainty
1	Conducted Output Power	0.66
2	Peak-to-Average Ratio	-
3	99% Occupied Bandwidth & 26 dB Bandwidth	0.002%
4	Band Edge	1.68dB
5	Conducted Spurious Emissions	1.68dB
6	Frequency stability	0.02ppm
7	Radiated Spurious Emission	4.54dB for 30MHz-1GHz
	Tradition Openious Emission	5.10dB for above 1GHz

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=1.96.

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4.7. Equipments Used during the Test

•	Conducted test item						
Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
0	Signal and spectrum Analyzer	R&S	HTWE0242	FSV40	100048	2022/08/25	2023/08/24
0	Signal & Spectrum Analyzer	R&S	HTWE0262	FSW26	103440	2022/08/25	2023/08/24
•	Spectrum Analyzer	Agilent	HTWE0286	N9020A	MY50510187	2022/08/25	2023/08/24
•	Radio communication tester	R&S	HTWE0287	CMW500	137688-Lv	2022/08/25	2023/08/24
•	Test software	Tonscend	N/A	JS1120	N/A	N/A	N/A

•	Radiated Spurious Emission						
Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
•	Semi-Anechoic Chamber	Albatross projects	HTWE0122	SAC-3m-01	C11121	2018/09/27	2023/09/26
•	Spectrum Analyzer	R&S	HTWE0098	FSP40	100597	2022/08/25	2023/08/24
•	Loop Antenna	R&S	HTWE0170	HFH2-Z2	100020	2021/04/06	2024/04/05
•	Broadband Horn Antenna	SCHWARZBECK	HTWE0103	BBHA9170	BBHA9170472	2020/04/27	2023/04/26
•	Ultra-Broadband Antenna	SCHWARZBECK	HTWE0123	VULB9163	538	2021/04/06	2024/04/05
•	Horn Antenna	SCHWARZBECK	HTWE0126	9120D	1011	2020/04/01	2023/03/31
•	Pre-amplifier	CD	HTWE0071	PAP-0102	12004	2022/11/04	2023/11/03
•	Broadband Preamplifier	SCHWARZBECK	HTWE0201	BBV 9718	9718-248	2022/02/28	2023/02/27
•	RF Connection Cable	HUBER+SUHNER	HTWE0120-01	6m 18GHz S Serisa	N/A	2022/02/25	2023/02/24
•	RF Connection Cable	HUBER+SUHNER	HTWE0120-02	6m 3GHz RG Serisa	N/A	2022/02/25	2023/02/24
•	RF Connection Cable	HUBER+SUHNER	HTWE0119-05	6m 3GHz RG Serisa	N/A	2022/02/25	2023/02/24
•	RF Connection Cable	HUBER+SUHNER	HTWE0120-04	6m 3GHz RG Serisa	N/A	2022/02/25	2023/02/24
•	EMI Test Software	Audix	N/A	E3	N/A	N/A	N/A

•	Auxiliary Equipment						
Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
•	Climate chamber	ESPEC	HTWE0254	GPL-2	N/A	2022/08/29	2023/08/28
•	DC Power Supply	Gwinstek	HTWE0274	SPS-2415	GER835793	N/A	N/A

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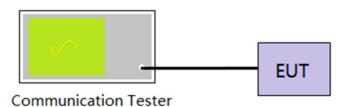
5. TEST CONDITIONS AND RESULTS

5.1. Conducted Output Power

LIMIT

N/A

TEST CONFIGURATION



TEST PROCEDURE

- 1. The EUT output port was connected to communication tester.
- 2. Set EUT at maximum power through communication tester.
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Measure the maximum burst average power.

TEST MODE:

Please refer to the clause 4.2

TEST RESULTS

Refer to appendix A on the section 8 appendix report

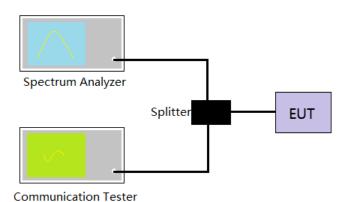
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5.2. Peak-to-Average Ratio

LIMIT

13dB

TEST CONFIGURATION



TEST PROCEDURE

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. Center Frequency = Carrier frequency, RBW > Emission bandwidth of signal
- 4. The signal analyzer was set to collect one million samples to generate the CCDF curve
- 5. The measurement interval was set depending on the type of signal analyzed.
 - i. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms.
 - ii. For bursttransmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that issynced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in whichthetransmitter is operating at maximum power
- 6. Record the maximum PAPR level associated with a probability of 0.1%.

TEST MODE:

Please refer to the clause 4.2

TEST RESULTS

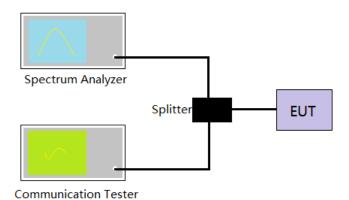
Refer to appendix B on the section 8 appendix report

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5.3. 99% Occupied Bandwidth & 26 dB Bandwidth

LIMIT N/A

TEST CONFIGURATION



TEST PROCEDURE

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. Spectrum analyzer setting as follow:

Center Frequency= Carrier frequency, RBW=1% to 5% of the anticipated OBW, VBW= 3 * RBW, Detector=Peak,

Trace maximum hold.

4. Record the value of 99% Occupied bandwidth and 26dB bandwidth.

TEST MODE:

Please refer to the clause 4.2

TEST RESULTS

Refer to appendix C on the section 8 appendix report

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5.4. Band Edge

LIMIT

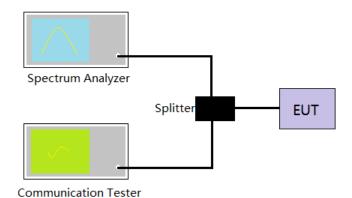
Part 24.238 and Part 22.917 and Part 27.53 specify that the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB.

The specification that emissions shall be attenuated below the transmitter power (P) by at least 43 + 10 log (P) dB, translates in the relevant power range (1 to 0.001 W) to -13 dBm. At 1 W the specified minimum attenuation becomes 43 dB and relative to a 30 dBm (1 W) carrier becomes a limit of -13 dBm. At 0.001 W (0 dBm) the minimum attenuation is 13 dB, which again yields a limit of -13 dBm. In this way a translation of the specification from relative to absolute terms is carried out.

LTE Band 7

Part 27.53 m(4) For mobile digital stations, the attenuation factor shall be not less than $40 + 10 \log (P)$ dB on all frequencies between the channel edge and 5 megahertz from the channel edge, $43 + 10 \log (P)$ dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and $55 + 10 \log (P)$ dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section.

TEST CONFIGURATION



TEST PROCEDURE

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. The band edges of low and high channels were measured.
- 4. Spectrum analyzer setting as follow:
 - RBW= no less than 1% of the OBW, VBW =3 * RBW, Sweep time= Auto
- 5. Record the test plot.

TEST MODE:

Please refer to the clause 4.2

TEST RESULTS

Refer to appendix D on the section 8 appendix report

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5.5. Conducted Spurious Emissions

LIMIT

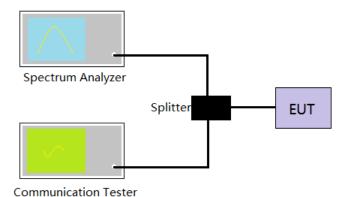
Part 24.238 and Part 22.917 and Part 27.53 specify that the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB.

The specification that emissions shall be attenuated below the transmitter power (P) by at least 43 + 10 log (P) dB, translates in the relevant power range (1 to 0.001 W) to -13 dBm. At 1 W the specified minimum attenuation becomes 43 dB and relative to a 30 dBm (1 W) carrier becomes a limit of -13 dBm. At 0.001 W (0 dBm) the minimum attenuation is 13 dB, which again yields a limit of -13 dBm. In this way a translation of the specification from relative to absolute terms is carried out.

LTE Band 7

Part 27.53 m(4) For mobile digital stations, the attenuation factor shall be not less than 40 + 10 log (P) dB on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition, the attenuation factor shall not be less that 43 + 10 log (P) dB on all frequencies between 2490.5 MHz and 2496 MHz and 55 + 10 log (P) dB at or below 2490.5 MHz. Mobile Satellite Service licensees operating on frequencies below 2495 MHz may also submit a documented interference complaint against BRS licensees operating on channel BRS Channel 1 on the same terms and conditions as adjacent channel BRS or EBS licensees. Limit <-25 dBm

TEST CONFIGURATION



TEST PROCEDURE

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. Spectrum analyzer setting as follow:

Below 1GHz, RBW=100KHz, VBW = 300KHz, Detector=Peak, Sweep time= Auto Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peak, Sweep time= Auto Scan frequency range up to 10th harmonic.

Record the test plot.

TEST MODE:

Please refer to the clause 4.2

TEST RESULTS

Refer to appendix E on the section 8 appendix report

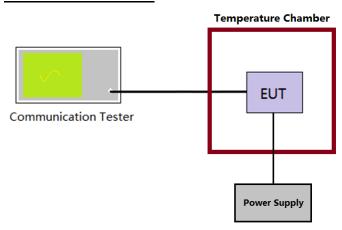
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5.6. Frequency stability VS Temperature measurement

LIMIT

2.5ppm

TEST CONFIGURATION



TEST PROCEDURE

- 1. The equipment under test was connected to an external DC power supply and input rated voltage.
- 2. The EUT output port was connected to communication tester.
- 3. The EUT was placed inside the temperature chamber.
- 4. Turn EUT off and set the chamber temperature to –30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency.
- 5. Repeat step 4 measure with 10°C increased per stage until the highest temperature of +50°C reached.

TEST MODE:

Please refer to the clause 4.2

TEST RESULTS

Refer to appendix F on the section 8 appendix report

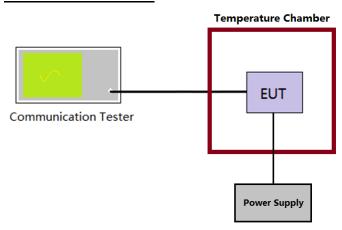
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5.7. Frequency stability VS Voltage measurement

LIMIT

2.5ppm

TEST CONFIGURATION



TEST PROCEDURE

- 1. The equipment under test was connected to an external DC power supply and input rated voltage.
- 2. The EUT output port was connected to communication tester.
- 3. The EUT was placed inside the temperature chamber at 25°C
- 4. The power supply voltage to the EUT was varied ±15% of the nominal value measured at the input to the EUT
- 5. Record the maximum frequency change.

TEST MODE:

Please refer to the clause 4.2

TEST RESULTS

Refer to appendix F on the section 8 appendix report

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5.8. ERP and EIRP

LIMIT

LTE Band 2/7: 2W(33dBm) EIRP LTE Band 4/66: 1W(30dBm) EIRP LTE Band 5: 7W(38.50dBm) ERP LTE Band 12/13: 3W(34.77dBm) ERP

TEST PROCEDURE

- 1. According to the power tested in section 5.1, select the maximum power in each mode, and use the following formula to calculate the corresponding ERP/EIRP.
- 2. ERP = conducted power + Gain(dBd)
- 3. EIRP = conducted power + Gain(dBi)

ERP = EIRP - 2.15

TEST RESULTS

$oxed{oxed}$ Passed	☐ Not Applicable
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Refer to appendix G on the section 8 appendix report

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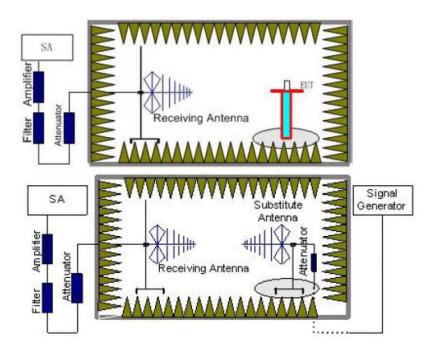
5.9. Radiated Spurious Emission

LIMIT

LTE Band 2/4/5/12/13/66: -13dBm;

LTE Band 7: -25dBm

TEST CONFIGURATION



TEST PROCEDURE

- 1. Place the EUT in the center of the turntable.
 - a) For radiated emissions measurements performed at frequencies less than or equal to 1 GHz, the EUT shall be placed on a RF-transparent table at a nominal height of 80 cm above the reference ground plane
 - b) For radiated measurements performed at frequencies above 1 GHz, the EUT shall be placed on an RF transparent table at a nominal height of 1.5 m above the ground plane.
- 2. Unless the EUT uses an integral antenna, the EUT shall be terminated with a non-radiating transmitter load. In cases where the EUT uses an adjustable antenna, the antenna shall be adjusted through typical positions and lengths to maximize emissions levels.
- 3. The EUT shall be tested while operating on the frequency per manufacturer specification. Set the transmitter to operate in continuous transmit mode.
- Receiver or Spectrum set as follow:

Below 1GHz, RBW=100kHz, VBW=300kHz, Detector=Peak, Sweep time=Auto

Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peck, Sweep time=Auto

- 5. Each emission under consideration shall be evaluated:
 - a) Raise and lower the measurement antenna from 1 m to 4 m, as necessary to enable detection of the maximum emission amplitude relative to measurement antenna height.
 - b) Rotate the EUT through 360° to determine the maximum emission level relative to the axial position.
 - c) Return the turntable to the azimuth where the highest emission amplitude level was observed.
 - d) Vary the measurement antenna height again through 1 m to 4 m again to find the height associated with the maximum emission amplitude.
 - e) Record the measured emission amplitude level and frequency
- 6. Repeat step 5 for each emission frequency with the measurement antenna oriented in both the horizontal

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and vertical polarizations to determine the orientation that gives the maximum emissions amplitude.

- Set-up the substitution measurement with the reference point of the substitution antenna located as near
 as possible to where the center of the EUT radiating element was located during the initial EUT
 measurement.
- 8. Maintain the previous measurement instrument settings and test set-up, with the exception that the EUT is removed and replaced by the substitution antenna.
- 9. Connect a signal generator to the substitution antenna; locate the signal generator so as to minimize any potential influences on the measurement results. Set the signal generator to the frequency where emissions are detected, and set an output power level such that the radiated signal can be detected by the measurement instrument, with sufficient dynamic range relative to the noise floor.
- 10. For each emission that was detected and measured in the initial test
 - a) Vary the measurement antenna height between 1 m to 4 m to maximize the received (measured) signal amplitude.
 - b) Adjust the signal generator output power level until the amplitude detected by the measurement instrument equals the amplitude level of the emission previously measured directly in step 5 and step 6.
 - Record the output power level of the signal generator when equivalence is achieved in step b).
- 11. Repeat step 8 through step 10 with the measurement antenna oriented in the opposite polarization.
- 12. Calculate the emission power in dBm referenced to a half-wave dipole using the following equation:

Pe = Ps(dBm) - cable loss (dB) + antenna gain (dBd)

where

Pe = equivalent emission power in dBm

Ps = source (signal generator) power in dBm

NOTE—dBd refers to the measured antenna gain in decibels relative to a half-wave dipole.

13. Correct the antenna gain of the substitution antenna if necessary to reference the emission power to a half-wave dipole. When using measurement antennas with the gain specified in dBi, the equivalent dipole-referenced gain can be determined from:

gain (dBd) = gain (dBi) - 2.15 dB.

If necessary, the antenna gain can be calculated from calibrated antenna factor information

14. Provide the complete measurement results as a part of the test report.

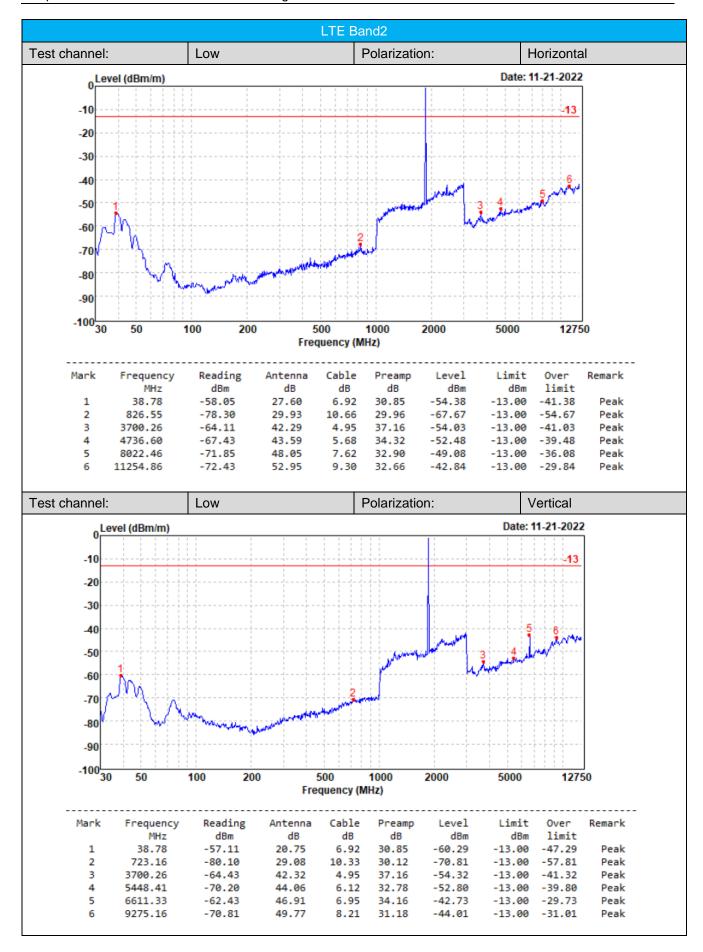
TEST MODE:

Please refer to the clause 4.2

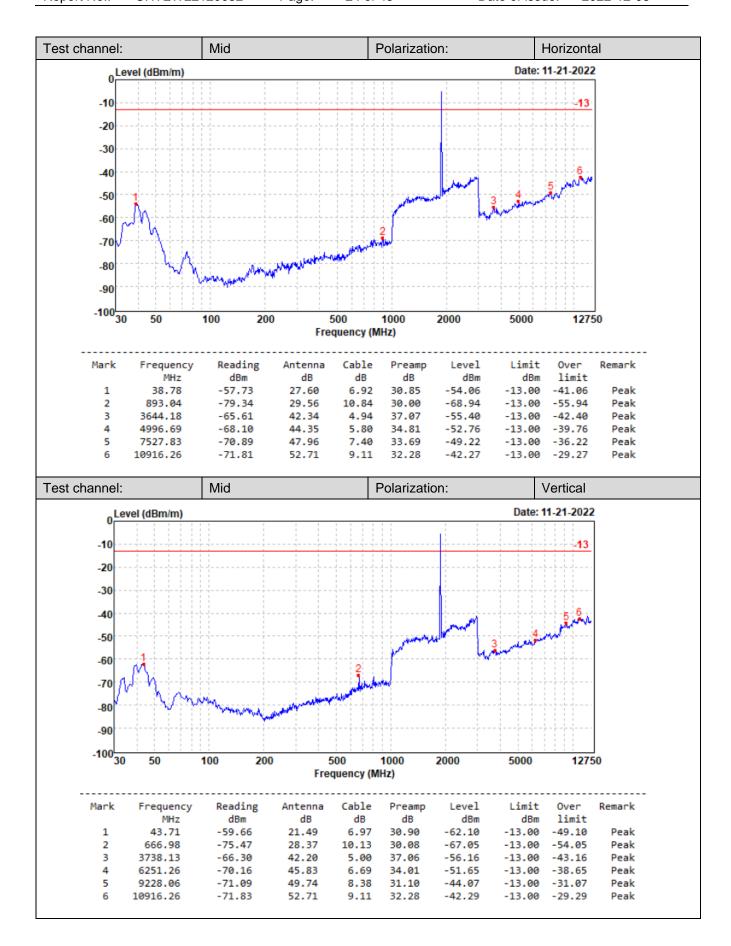
TEST RESULTS

Note: only show the worse case for QPSK modulation.

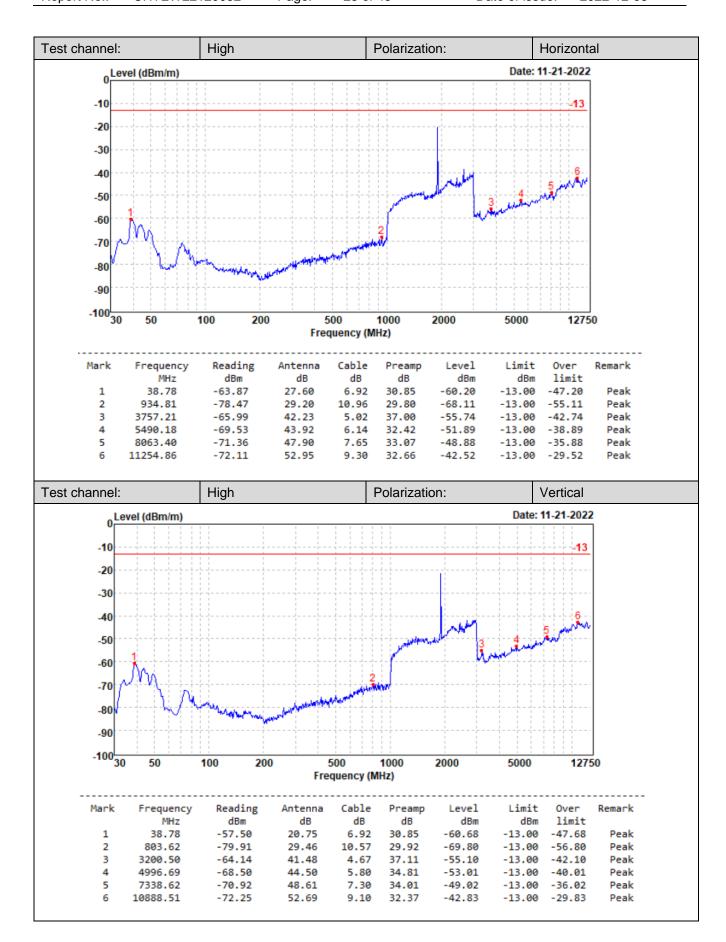
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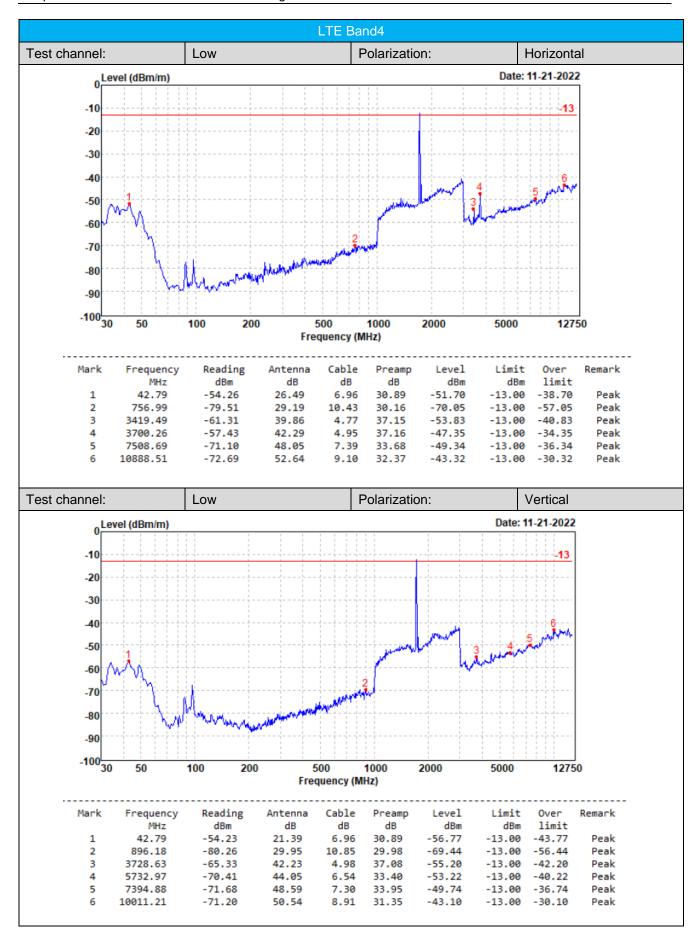
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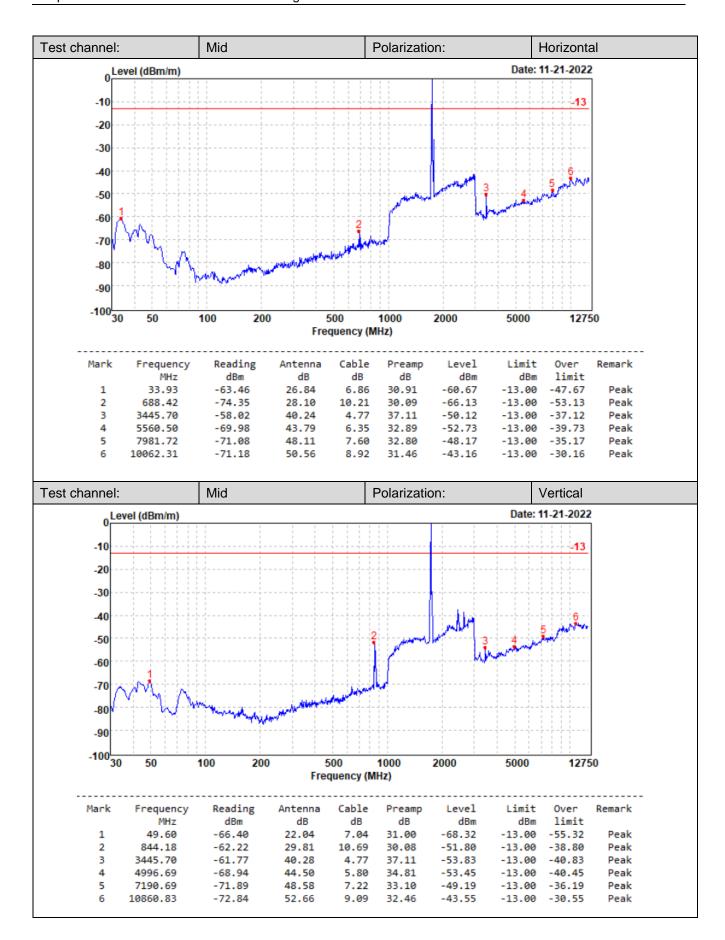
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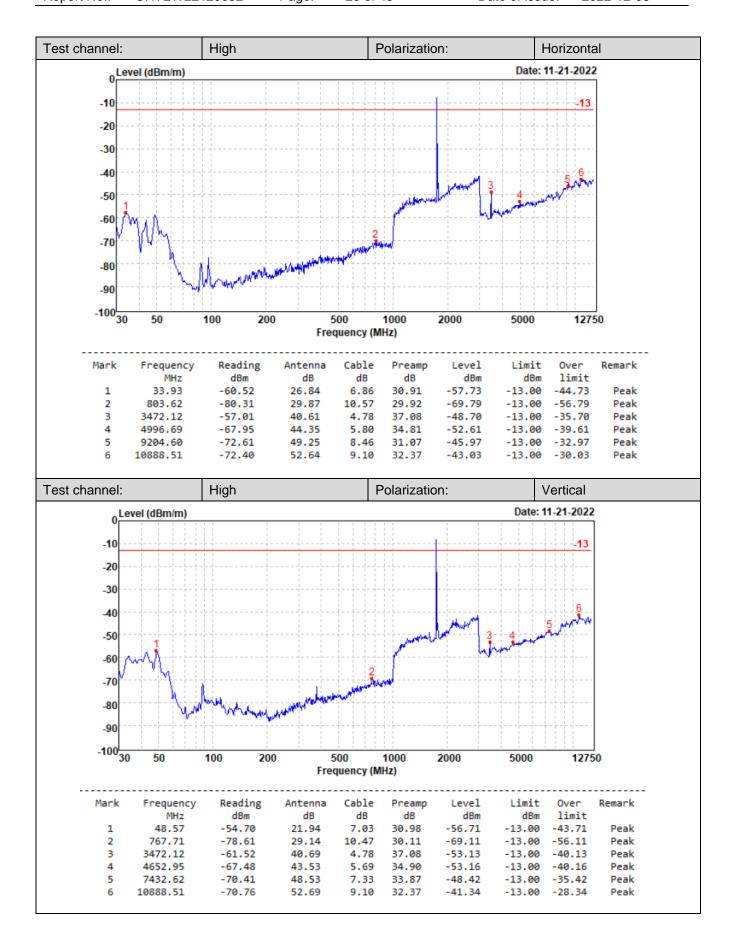
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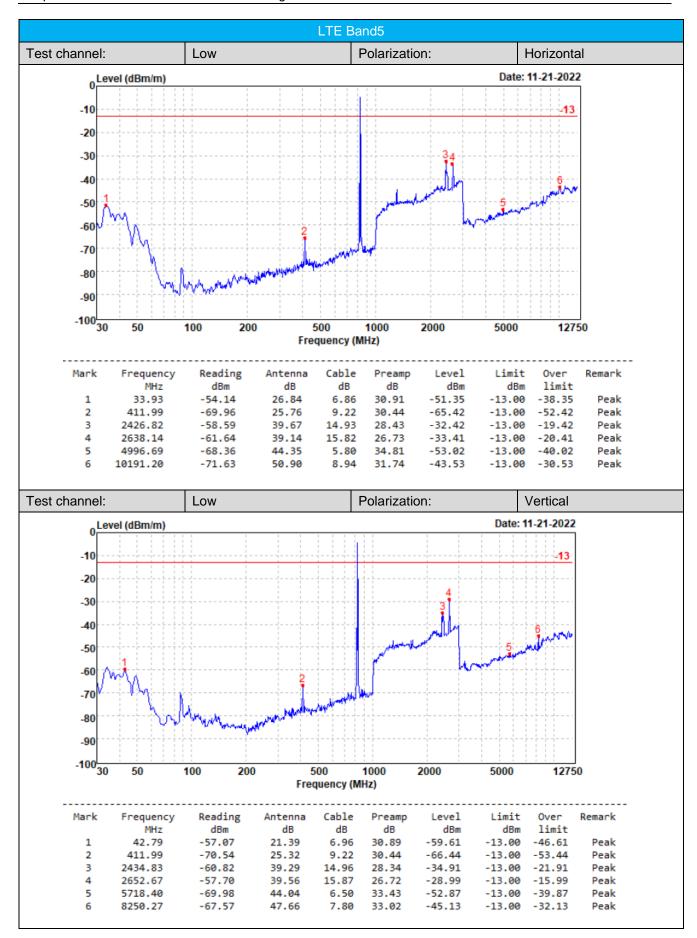
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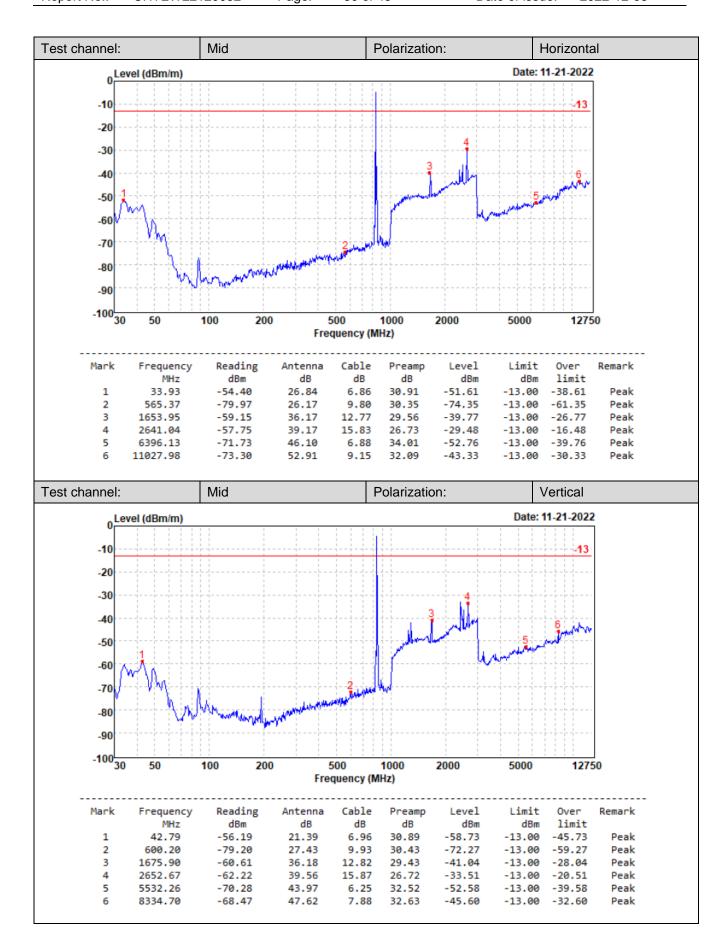
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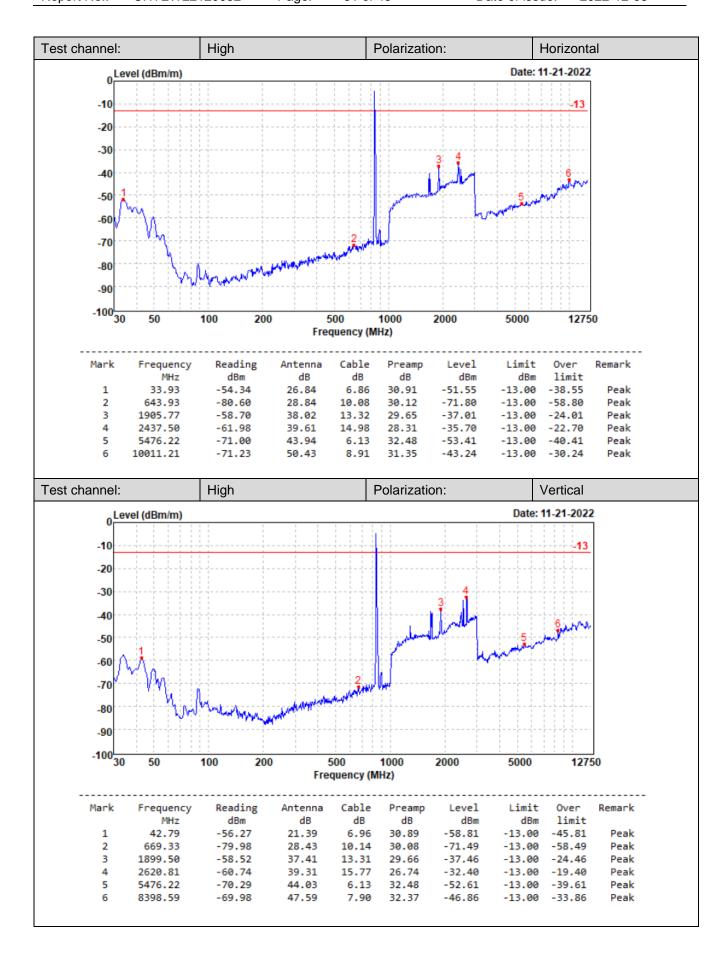
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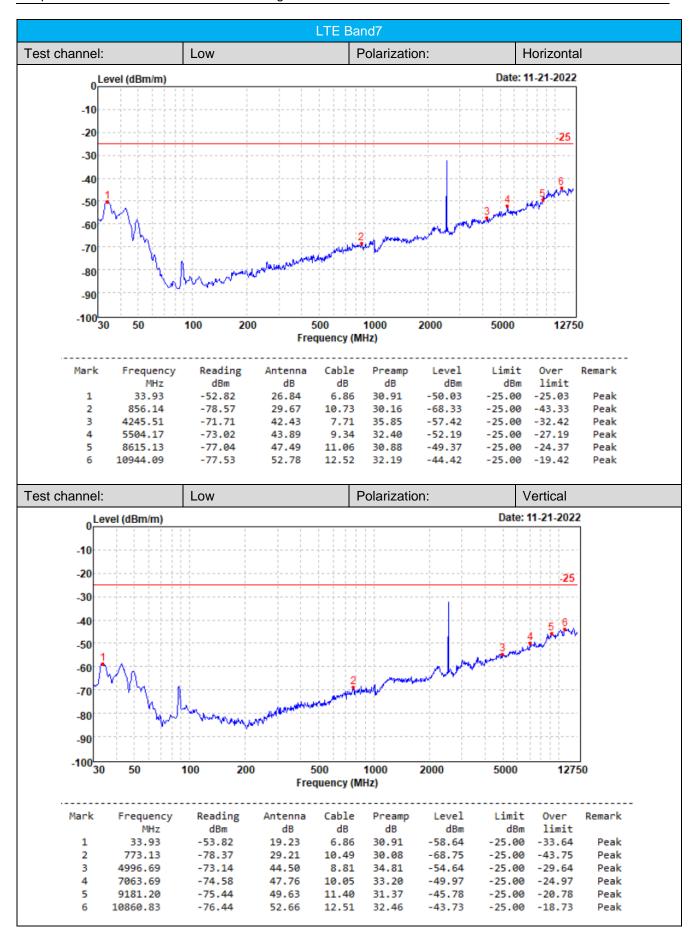
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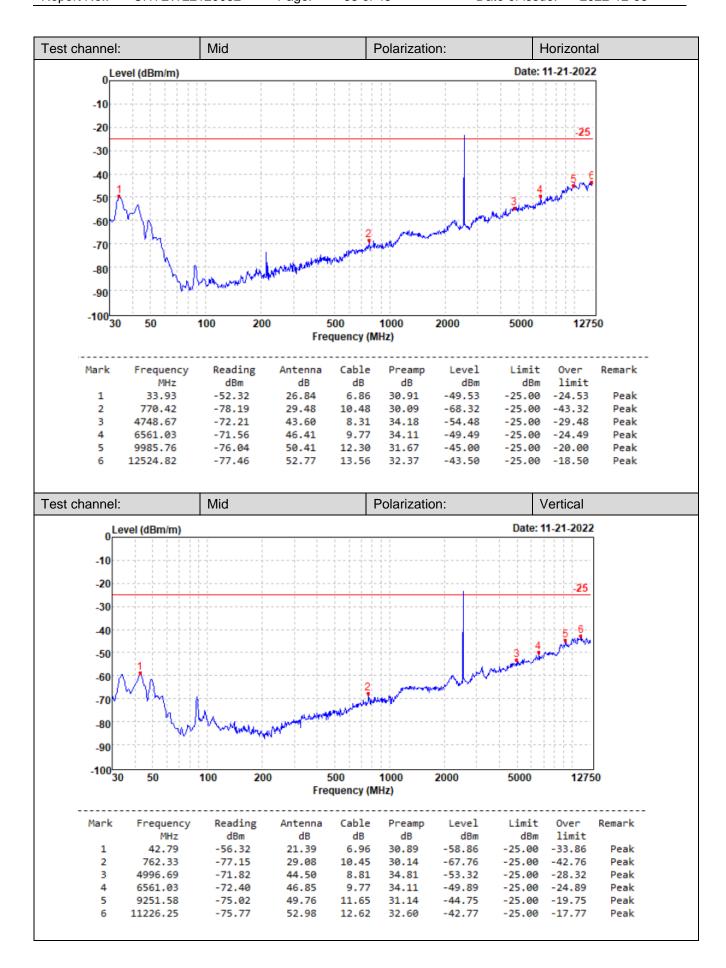
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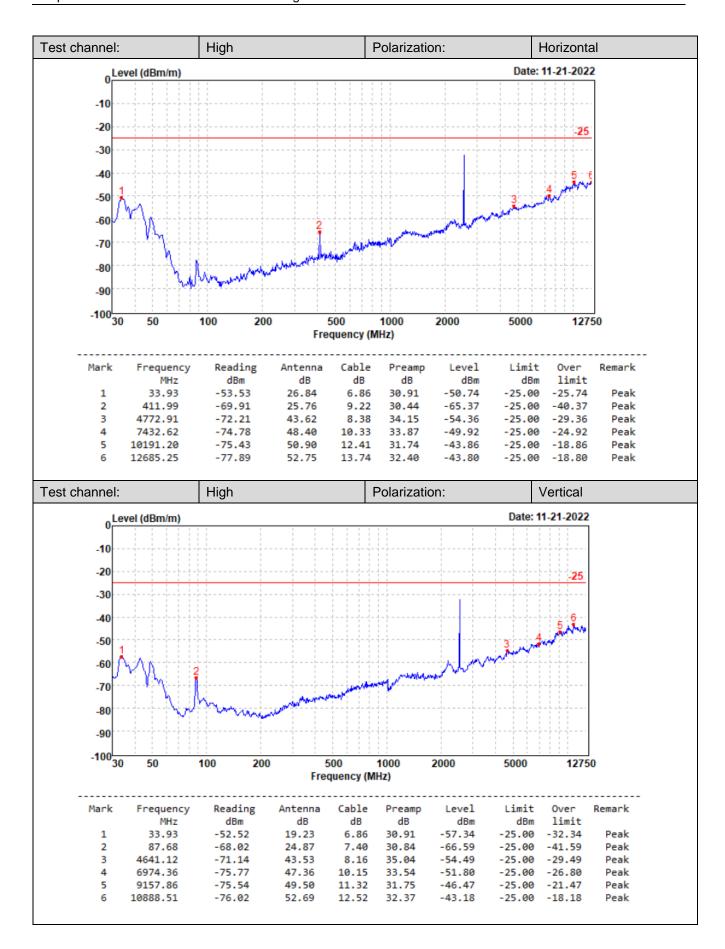
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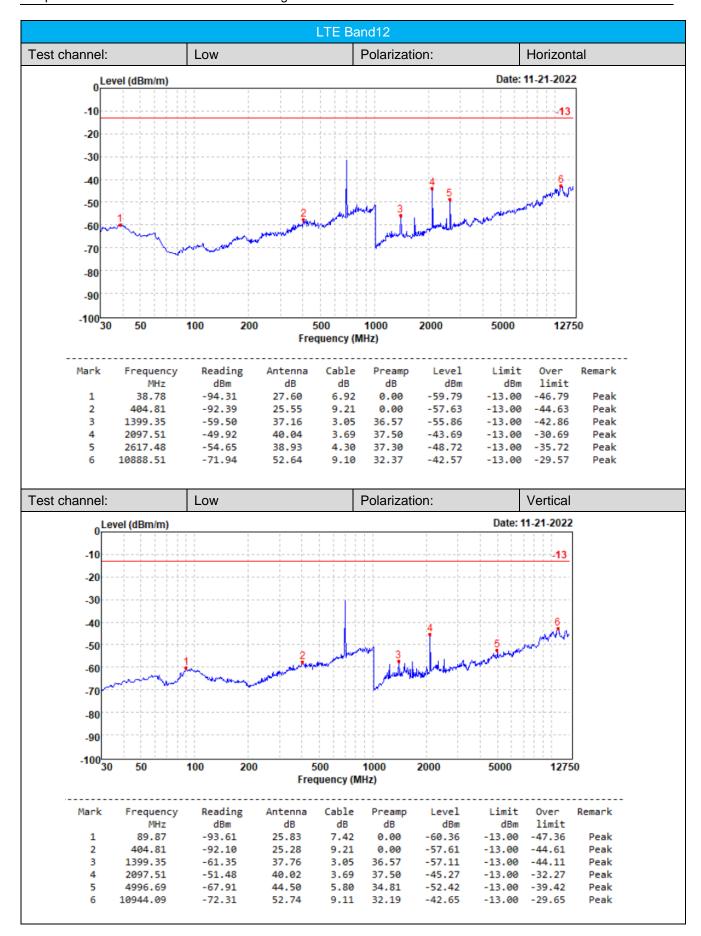
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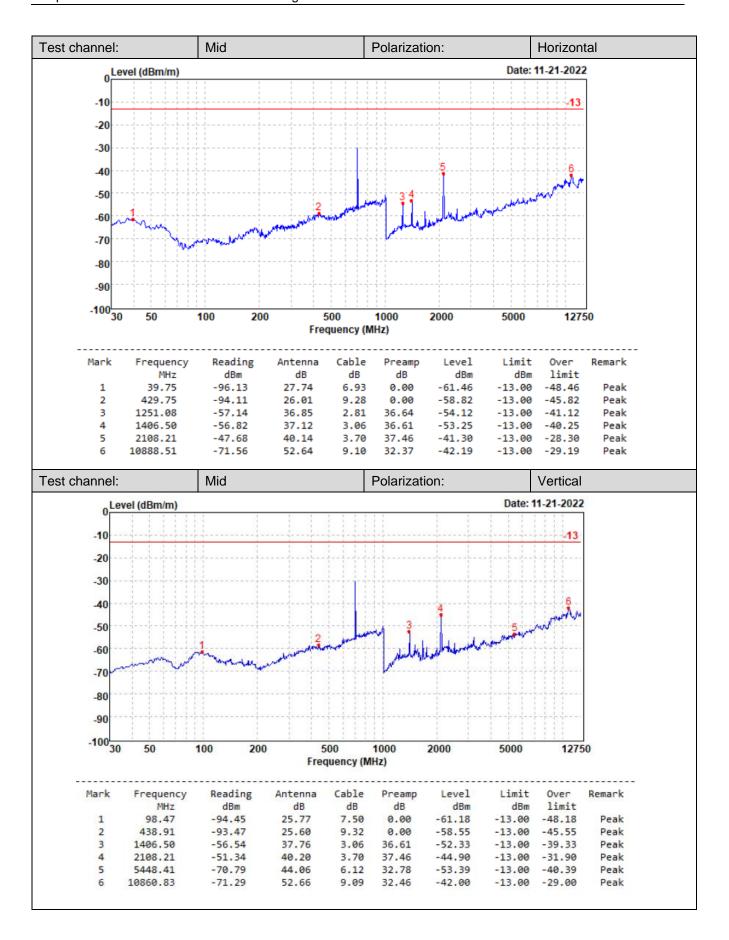
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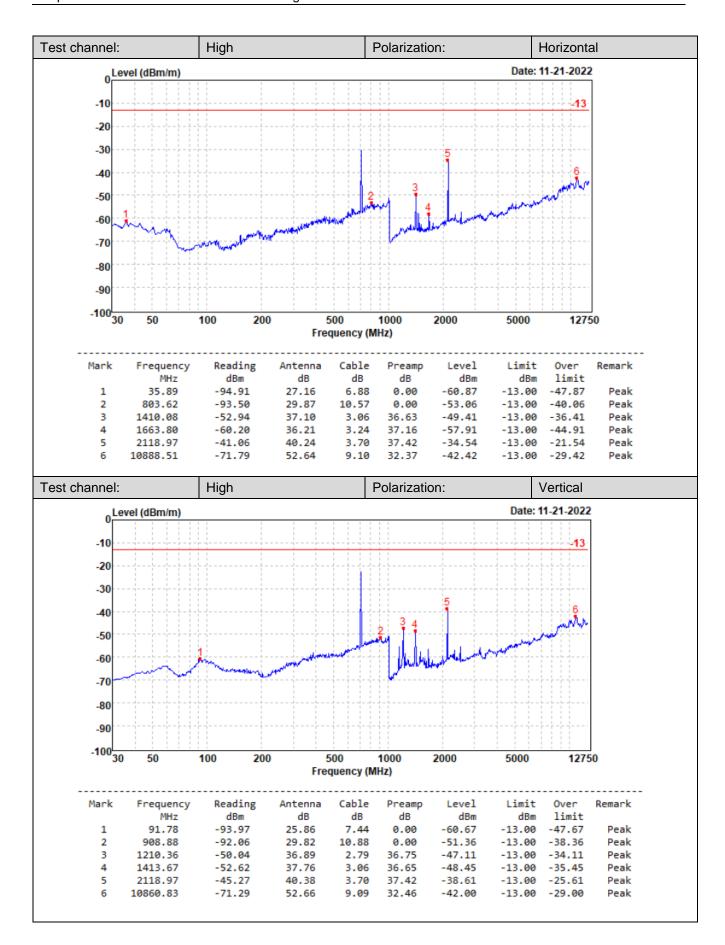
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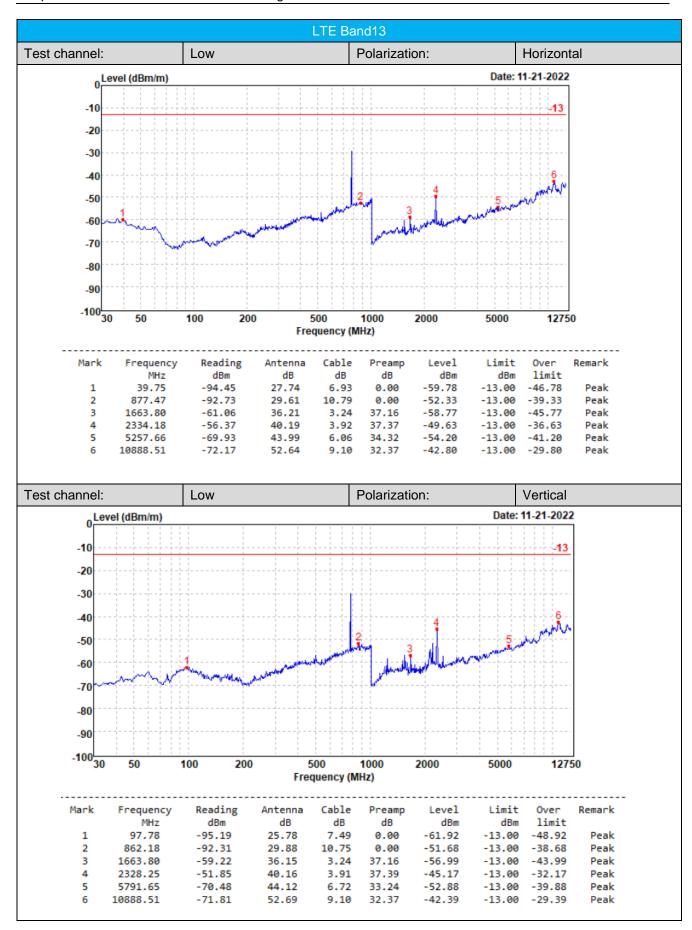
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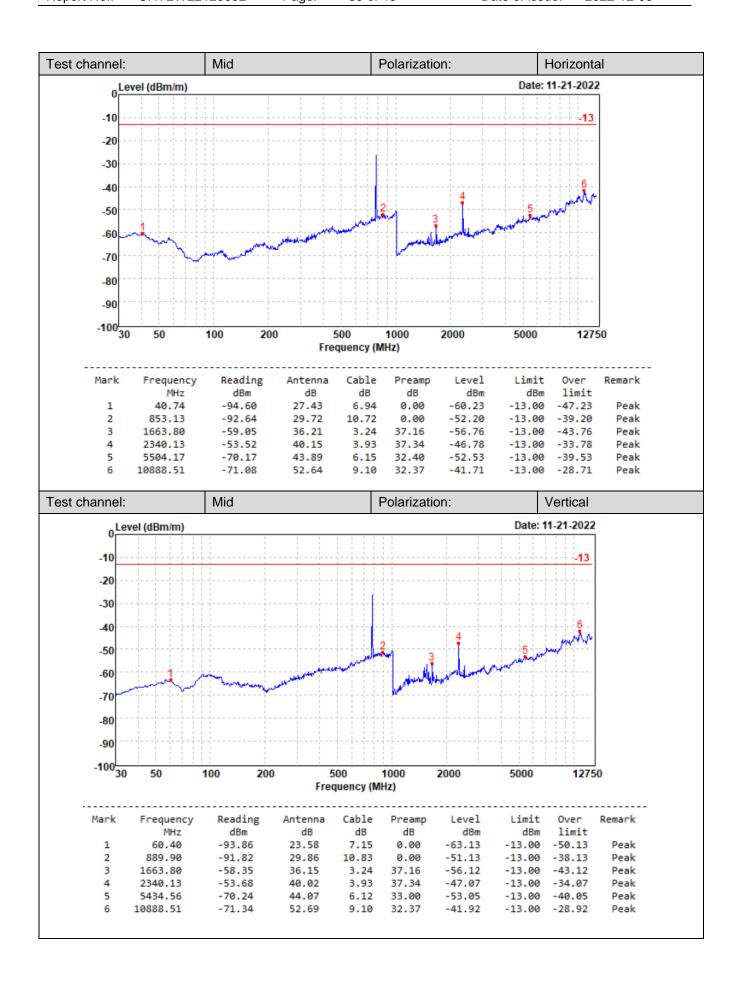
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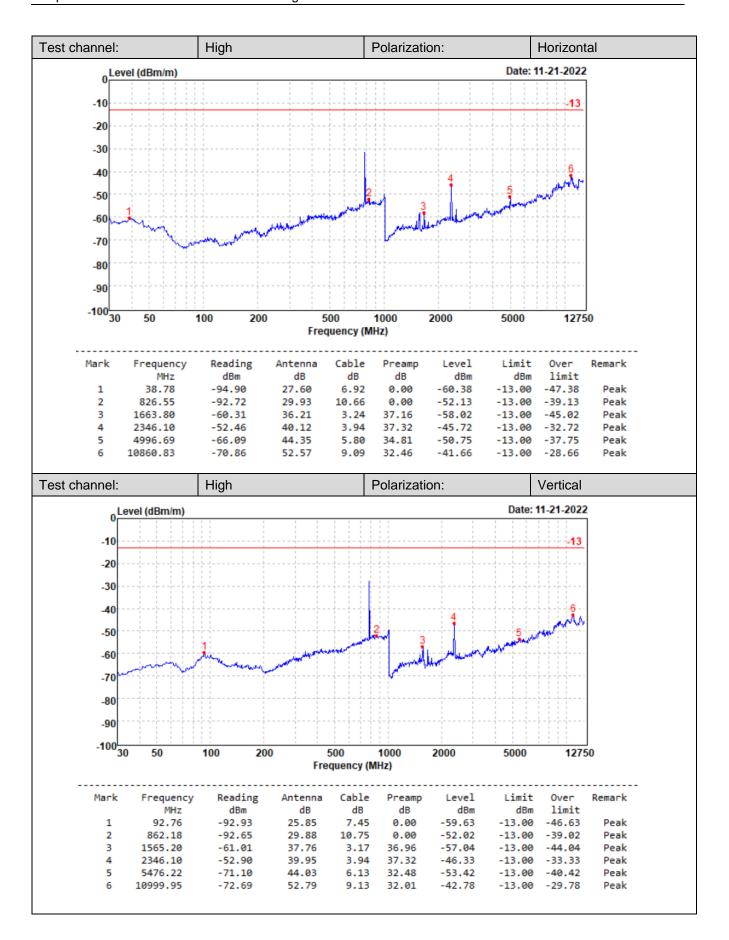
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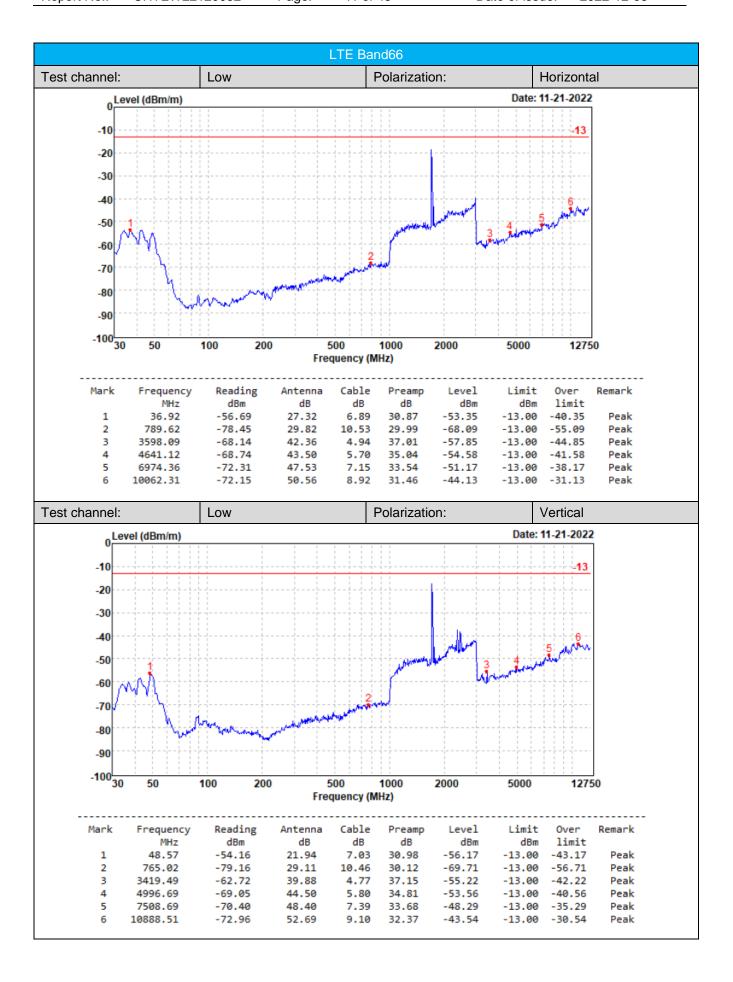
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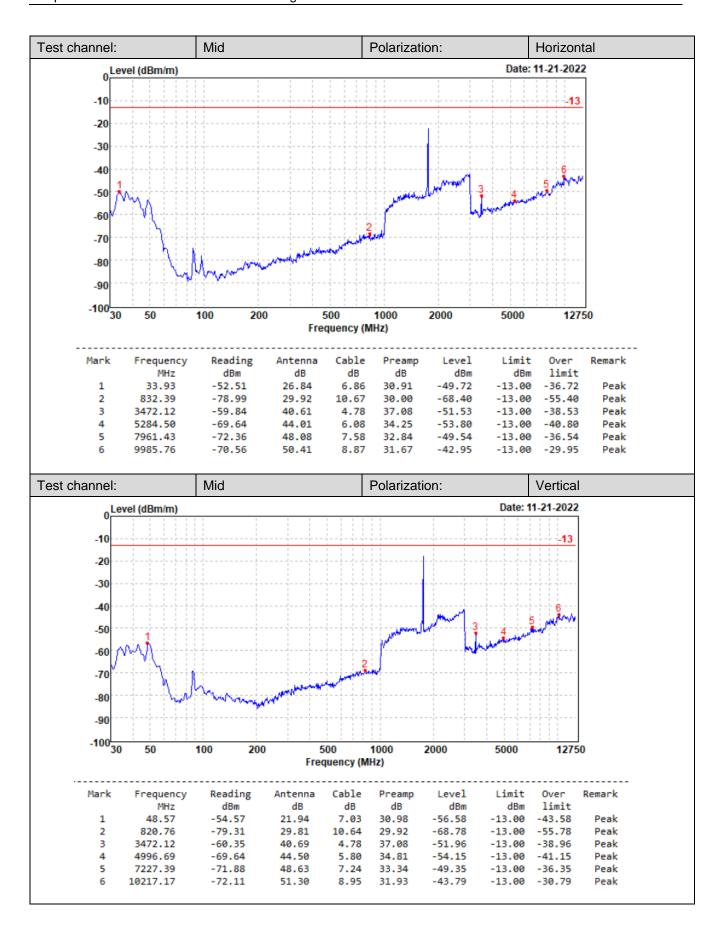
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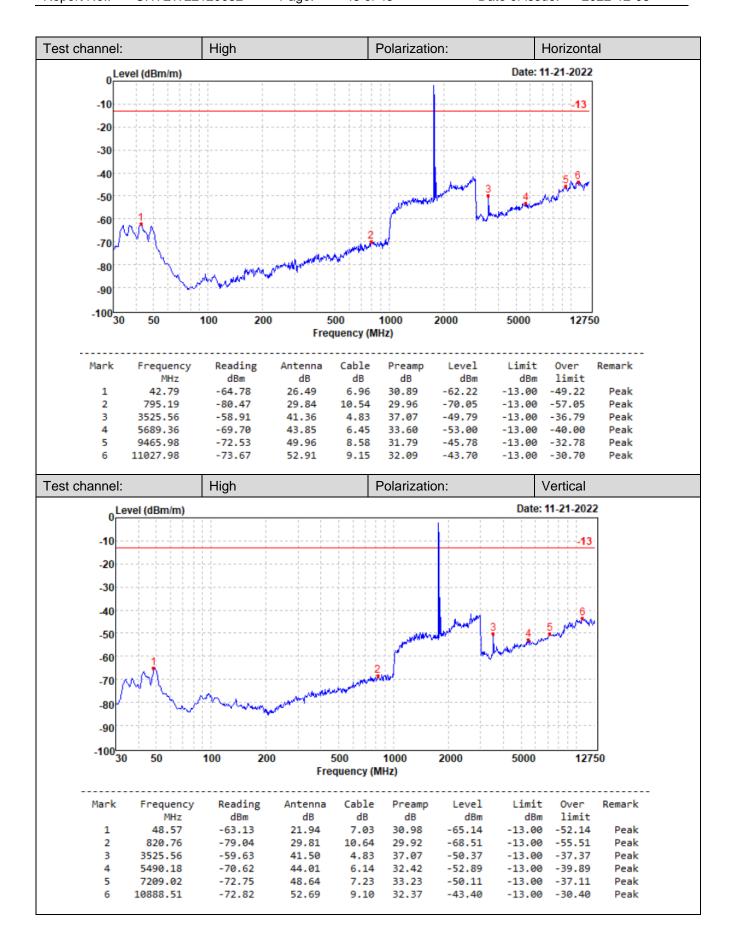
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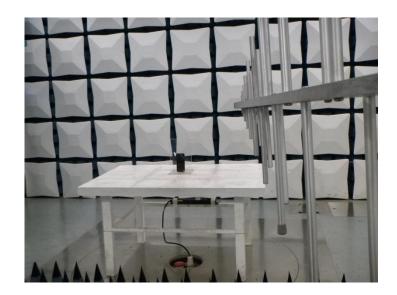


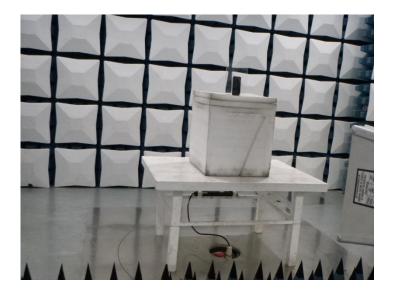
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6. TEST SETUP PHOTOS OF THE EUT







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7. EXTERNAL AND INTERNAL PHOTOS OF THE EUT

Refer to the test report No.: CHTEW22120050

8. APPENDIX REPORT